


<b>Search Notes</b>  	<b>Application/Control No.</b>  10594500	<b>Applicant(s)/Patent Under Reexamination</b>  IWASAKI, MITSUTAKA
	<b>Examiner</b>  shih-wen hsieh	<b>Art Unit</b>  2861

SEARCHED			
Class	Subclass	Date	Examiner
347	updated	3-11-08	SWH

SEARCH NOTES		
Search Notes	Date	Examiner
east text search	3-11-08	SWH

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
347	29,30,32,23	3-11-08	SWH